Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/668,203	KANIE, HIDEKI
Examiner	Art Unit
Jack W. Lavinder	3677

SEARCHED						
	SEARCHED					
Class	Subclass	Date	Examiner			
411	173-175	9/12/2005	JWL			
	44,340					
	908					
24	458					
	297					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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